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HI1171

专业PCB打样工厂,24小时加急出货

August 1997

8-Bit, 40 MSPS, High Speed D/A Converter

The HI1171 is an 8-bit, 40MHz, high speed D/A converter. The converter incorporates an 8-bit input data register with

blanking capability, and current outputs. The HI1171 fea-

tures low glitch outputs. The architecture is a current cell

The HI1171 is available in an Industrial temperature range

and is offered in a 24 lead (200 mil) SOIC plastic package.

For dual version, please refer to the HI1177 Data Sheet.

PACKAGE

Evaluation Board

24 Ld SOIC

PKG. NO.

M24.2-S

For triple version, please refer to the HI1178 Data Sheet.

arrangement to provide low linearity errors.

TEMP. RANGE

(°C)

-40 to 85

25

Ordering Information

PART NUMBER

HI1171JCB

HI1171-EV

Description

Features

- Throughput Rate 40MHz
- Resolution8-Bit
- Low Glitch Noise
- Single Supply Operation+5V
- Low Power Consumption (Max)80mW
- Evaluation Board Available (HI1171-EV)
- Direct Replacement for the Sony CXD1171

Applications

- Wireless Telecommunications
- Signal Reconstruction
- Direct Digital Synthesis
- Imaging
- Presentation and Broadcast Video
- Graphics Displays
- Signal Generators



CALITION: These devices are considive to electrostatic discharge: follow preper IC Handling Presedures

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Absolute Maximum Ratings

Digital Supply Voltage DV _{DD} to DV _{SS}	.+7.0V
Analog Supply Voltage AV _{DD} to AV _{SS}	.+7.0V
Input Voltage V _{DD} to	V _{SS} V
Output CurrentOmA to	o 15mA

Operating Conditions

Temperature Range-40°C to 85°C

Thermal Information

Thermal Resistance (Typical, Note 1)	θ _{JA} (^o C/W)
SOIC Package	98
Maximum Junction Temperature, Plastic Package	150 ⁰ C
Maximum Storage Temperature Range	65°C to 150°C
Maximum Lead Temperature (Soldering 10s)	300 ⁰ C
(SOIC - Lead Tips Only)	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. θ_{JA} is measured with the component mounted on an evaluation PC board in free air.

PARAMETER	TEST CONDITIONS	MIN	ТҮР	МАХ	UNITS
SYSTEM PERFORMANCE					
Resolution, n		-	8	-	Bits
Integral Linearity Error, INL	f _S = 40MHz (End Point)	-0.5	-	1.3	LSB
Differential Linearity Error, DNL	f _S = 40MHz	-	-	±0.25	LSB
Offset Error, V _{OS}	(Note 2)	-	-	1	mV
Full Scale Error, FSE (Adjustable to Zero)	(Note 2)	-	-	±13	LSB
Full Scale Output Current, I _{FS}		-	10	15	mA
Full Scale Output Voltage, V _{FS}		1.9	2.0	2.1	V
Output Voltage Range, V _{FSR}		0.5	2.0	2.1	V
DYNAMIC CHARACTERISTICS			-		
Throughput Rate	See Figure 7	40.0	-	-	MHz
Glitch Energy, GE	R _{OUT} = 75Ω	-	30	-	pV-s
Differential Gain, ΔA_V (Note 3)		-	1.2	-	%
Differential Phase, ∆∳ (Note 3)		-	0.5	-	Degree
REFERENCE INPUT	•				
Voltage Reference Input Range		0.5	-	2.0	V
Reference Input Resistance	(Note 3)	1.0	-	-	MΩ
DIGITAL INPUTS	·				
Input Logic High Voltage, V _{IH}	(Note 3)	3.0	-	-	V
Input Logic Low Voltage, VIL	(Note 3)	-	-	1.5	V
Input Logic Current, I _{IL} , I _{IH}	(Note 3)	-	-	±5.0	μA
Digital Input Capacitance, C _{IN}	(Note 3)	-	5.0	-	pF
TIMING CHARACTERISTICS		•			-
Data Setup Time, t _{SU}	See Figure 1	5	-	-	ns
Data Hold Time, t _{HLD}	See Figure 1	10	-	-	ns
	•				

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Electrical Specifications $AV_{DD} = +4.75V \text{ to } +5.25V, DV_{DD} = +4.75 \text{ to } +5.25V, V_{REF} = +2.0V, f_S = 40MHz, CLK Pulse Width = 12.5ns, T_A = 25^{\circ}C (Note 4) (Continued)$					
PARAMETER	TEST CONDITIONS	MIN	ТҮР	МАХ	UNITS
Propagation Delay Time, t _{PD}	See Figure 9	-	10	-	ns
Settling Time, t _{SET} (to ¹ / ₂ LSB)	See Figure 1	-	10	15	ns
CLK Pulse Width, t _{PW1} , t _{PW2}	See Figure 1	12.5	-	-	ns
POWER SUPPLY CHARACTERISITICS					
IAV _{DD}	14.3MHz, at Color Bar Data Input	-	10.9	11.5	mA
IDV _{DD}	14.3MHz, at Color Bar Data Input	-	4.2	4.8	mA
Power Dissipation	200Ω load at $2V_{P-P}$ Output	-	-	80	mW

NOTES:

2. Excludes error due to external reference drift.

3. Parameter guaranteed by design or characterization and not production tested.

4. Electrical specifications guaranteed only under the stated operating conditions.

Timing Diagram



FIGURE 1.

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24 PIN SOIC	PIN NAME	PIN DESCRIPTION
1-8	D0(LSB) thru D7(MSB)	Digital Data Bit 0, the Least Significant Bit thru Digital Data Bit 7, the Most Significant Bit.
9	BLNK	Blanking Line, used to clear the internal data register to the zero condition when High, normal operation when Low.
10, 13	DV _{SS}	Digital Ground.
11	VB	Voltage Bias, connect a $0.1 \mu F$ capacitor to $\text{DV}_{\text{SS}}.$
12	CLK	Data Clock Pin 100kHz to 40MHz.
14	AV _{SS}	Analog Ground.
15	I _{REF}	Current Reference, used to set the current range. Connect a resistor to AV_{SS} that is 16 times greater than the resistor on I_{OUT1} . (See Typical Applications Circuit).
16	V _{REF}	Input Reference Voltage used to set the output full scale range.
L	1	

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Pin Descriptions (Continued)					
24 PIN SOIC	PIN NAME	PIN DESCRIPTION			
17	VG	Voltage Ground, connect a 0.1 μ F capacitor to AV _{DD} .			
18, 19, 22	AV _{DD}	Analog Supply 4.75V to 7V.			
20	IOUT1	Current Output Pin.			
21	I _{OUT2}	Current Output pin used for a virtual ground connection. Usually connected to AV _{SS} .			
23, 24	DV _{DD}	Digital Supply 4.75V to 7V.			

Detailed Description

The HI1171 is an 8-bit, current out D/A converter. The DAC can convert at 40MHz and run on a single +5V supply. The architecture is an encoded, switched current cell arrangement.

Voltage Output Mode

The output current of the HI1171 can be converted into a voltage by connecting an external resistor to I_{OUT1} . To calculate the output resistor use the following equation:

$R_{OUT} = V_{FS} / I_{FS}$,

where V_{FS} can range from +0.5V to +2.0V and I_{FS} can range from 0mA to 15mA.

In setting the output current the I_{REF} pin should have a resistor connected to it that is 16 times greater than the output resistor:

 $R_{REF} = 16 \times R_{OUT}$

As the values of both R_{OUT} and R_{REF} increase, power consumption is decreased, but glitch energy and output settling time is increased.

Clock Phase Relationship

The internal latch is closed when the clock line is high. The latch can be cleared by the BLNK line. When BLNK is set (HIGH) the contents of the internal data latch will be cleared. When BLNK is low data is updated by the CLK.

Noise Reduction

To reduce power supply noise separate analog and digital power supplies should be used with 0.1μ F ceramic capacitors placed as close to the body of the HI1171 as possible. The analog (AV_{SS}) and digital (DV_{SS}) ground returns should be connected together back at the power supply to ensure proper operation from power up.



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